

MOTOROLA



SEMICONDUCTOR TECHNICAL DATA

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Hybrid Power Module

Integrated Power Stage for 3.0 hp Motor Drives

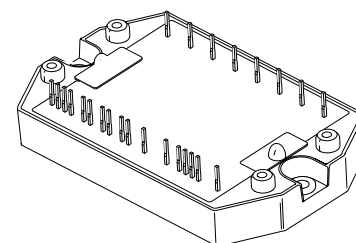
This module integrates a 3-phase input rectifier bridge, 3-phase output inverter and brake transistor/diode in a single convenient package. The output inverter utilizes advanced insulated gate bipolar transistors (IGBT) matched with free-wheeling diodes to give optimal dynamic performance. It has been configured for use as a three-phase motor drive module or for many other power switching applications. The top connector pins have been designed for easy interfacing to the user's control board.

- Short Circuit Rated 10 μ s @ 25°C
- Pin-to-Baseplate Isolation Exceeds 2500 Vac (rms)
- Convenient Package Outline
- UL  Recognized and Designed to Meet VDE 
- Access to Positive and Negative DC Bus

MHPM7B30A60B

Motorola Preferred Device

**30 AMP, 600 VOLT
HYBRID POWER MODULE**



PLASTIC PACKAGE
CASE 440A-01, Style 1

MAXIMUM DEVICE RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
INPUT RECTIFIER BRIDGE			
Repetitive Peak Reverse Voltage	V_{RRM}	600	V
Average Output Rectified Current (1)	I_O	30	A
Peak Non-repetitive Surge Current	I_{FSM}	360	A
OUTPUT INVERTER			
IGBT Reverse Voltage	V_{CES}	600	V
Gate-Emitter Voltage	V_{GES}	± 20	V
Continuous IGBT Collector Current	I_C	30	A
Peak IGBT Collector Current – (PW = 1.0 ms) (2)	$I_{C(pk)}$	60	A
Continuous Free-Wheeling Diode Current	I_F	30	A
Peak Free-Wheeling Diode Current – (PW = 1.0 ms) (2)	$I_{F(pk)}$	60	A
IGBT Power Dissipation	P_D	85	W
Free-Wheeling Diode Power Dissipation	P_D	40	W
IGBT Junction Temperature Range	T_J	- 40 to +125	$^\circ\text{C}$
Free-Wheeling Diode Junction Temperature Range	T_J	- 40 to +125	$^\circ\text{C}$

(1) 1 cycle = 50 or 60 Hz

(2) 1 ms = 1.0% duty cycle

Preferred devices are Motorola recommended choices for future use and best overall value.

MAXIMUM DEVICE RATINGS (continued) ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
BRAKE CIRCUIT			
IGBT Reverse Voltage	V_{CES}	600	V
Gate-Emitter Voltage	V_{GES}	± 20	V
Continuous IGBT Collector Current	I_C	30	A
Peak IGBT Collector Current (PW = 1.0 ms) (2)	$I_{C(pk)}$	60	A
IGBT Power Dissipation	PD	85	W
Diode Reverse Voltage	V_{RRM}	600	V
Continuous Output Diode Current	I_F	30	A
Peak Output Diode Current (PW = 1.0 ms) (2)	$I_{F(pk)}$	60	A

TOTAL MODULE

Isolation Voltage – (47–63 Hz, 1.0 Minute Duration)	V_{ISO}	2500	VAC
Ambient Operating Temperature Range	T_A	- 40 to + 85	$^\circ\text{C}$
Operating Case Temperature Range	T_C	- 40 to + 90	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	- 40 to +150	$^\circ\text{C}$
Mounting Torque	–	6.0	lb-in

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
INPUT RECTIFIER BRIDGE					
Reverse Leakage Current ($V_{RRM} = 600\text{ V}$)	I_R	–	10	50	μA
Forward Voltage ($I_F = 30\text{ A}$)	V_F	–	1.1	1.5	V
Thermal Resistance (Each Die)	$R_{\theta JC}$	–	–	2.7	$^\circ\text{C/W}$
OUTPUT INVERTER					
Gate-Emitter Leakage Current ($V_{CE} = 0\text{ V}$, $V_{GE} = \pm 20\text{ V}$)	I_{GES}	–	–	± 20	μA
Collector-Emitter Leakage Current ($V_{CE} = 600\text{ V}$, $V_{GE} = 0\text{ V}$) $T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	I_{CES}	– –	– –	100 2.0	μA mA
Gate-Emitter Threshold Voltage ($V_{CE} = V_{GE}$, $I_C = 1.0\text{ mA}$)	$V_{GE(th)}$	4.0	6.0	8.0	V
Collector-Emitter Breakdown Voltage ($I_C = 10\text{ mA}$, $V_{GE} = 0$)	$V_{(BR)CES}$	600	700	–	V
Collector-Emitter Saturation Voltage ($I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$)	$V_{CE(SAT)}$	–	2.3	3.5	V
Input Capacitance ($V_{GE} = 0\text{ V}$, $V_{CE} = 10\text{ V}$, $f = 1.0\text{ MHz}$)	C_{ies}	–	6600	–	pF
Input Gate Charge ($V_{CE} = 300\text{ V}$, $I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$)	Q_T	–	220	–	nC
Fall Time – Inductive Load ($V_{CE} = 300\text{ V}$, $I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$, $R_G = 150\ \Omega$)	t_{fi}	–	300	500	ns
Turn-On Energy ($V_{CE} = 300\text{ V}$, $I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$, $R_G = 150\ \Omega$)	$E_{(on)}$	–	–	2.5	mJ
Turn-Off Energy ($V_{CE} = 300\text{ V}$, $I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$, $R_G = 150\ \Omega$)	$E_{(off)}$	–	–	2.5	mJ
Diode Forward Voltage ($I_F = 30\text{ A}$, $V_{GE} = 0\text{ V}$)	V_F	–	1.35	2.2	V
Diode Reverse Recovery Time ($I_F = 30\text{ A}$, $V = 300\text{ V}$, $di/dt = 100\text{ A}/\mu\text{s}$)	t_{rr}	–	150	200	ns
Diode Stored Charge ($I_F = 30\text{ A}$, $V = 300\text{ V}$, $di/dt = 100\text{ A}/\mu\text{s}$)	Q_{rr}	–	750	900	nC
Thermal Resistance – IGBT (Each Die)	$R_{\theta JC}$	–	–	1.2	$^\circ\text{C/W}$
Thermal Resistance – Free-Wheeling Diode (Each Die)	$R_{\theta JC}$	–	–	2.7	$^\circ\text{C/W}$

(2) 1.0 ms = 1.0% duty cycle

ELECTRICAL CHARACTERISTICS (continued) ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
BRAKE CIRCUIT					
Gate-Emitter Leakage Current ($V_{CE} = 0\text{ V}$, $V_{GE} = \pm 20\text{ V}$)	I_{GES}	–	–	± 20	μA
Collector-Emitter Leakage Current ($V_{CE} = 600\text{ V}$, $V_{GE} = 0\text{ V}$) $T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	I_{CES}	– –	– –	100 2.0	μA mA
Gate-Emitter Threshold Voltage ($V_{CE} = V_{GE}$, $I_C = 1.0\text{ mA}$)	$V_{GE(th)}$	4.0	6.0	8.0	V
Collector-Emitter Breakdown Voltage ($I_C = 10\text{ mA}$, $V_{GE} = 0$)	$V_{(BR)CES}$	600	700	–	V
Collector-Emitter Saturation Voltage ($V_{GE} = 15\text{ V}$, $I_C = 30\text{ A}$)	$V_{CE(SAT)}$	–	2.3	3.5	V
Input Capacitance ($V_{GE} = 0\text{ V}$, $V_{CE} = 10\text{ V}$, $f = 1.0\text{ MHz}$)	C_{ies}	–	6600	–	pF
Input Gate Charge ($V_{CE} = 300\text{ V}$, $I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$)	Q_T	–	220	–	nC
Fall Time – Inductive Load ($V_{CE} = 300\text{ V}$, $I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$, $R_G = 150\ \Omega$)	t_{fi}	–	300	500	ns
Turn-On Energy ($V_{CE} = 300\text{ V}$, $I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$, $R_G = 150\ \Omega$)	$E_{(on)}$	–	–	2.5	mJ
Turn-Off Energy ($V_{CE} = 300\text{ V}$, $I_C = 30\text{ A}$, $V_{GE} = 15\text{ V}$, $R_G = 150\ \Omega$)	$E_{(off)}$	–	–	2.5	mJ
Diode Forward Voltage ($I_F = 30\text{ A}$)	V_F	–	1.35	2.0	V
Diode Reverse Leakage Current	I_R	–	–	50	μA
Thermal Resistance – IGBT	$R_{\theta JC}$	–	–	1.2	$^\circ\text{C/W}$
Thermal Resistance – Diode	$R_{\theta JC}$	–	–	2.7	$^\circ\text{C/W}$

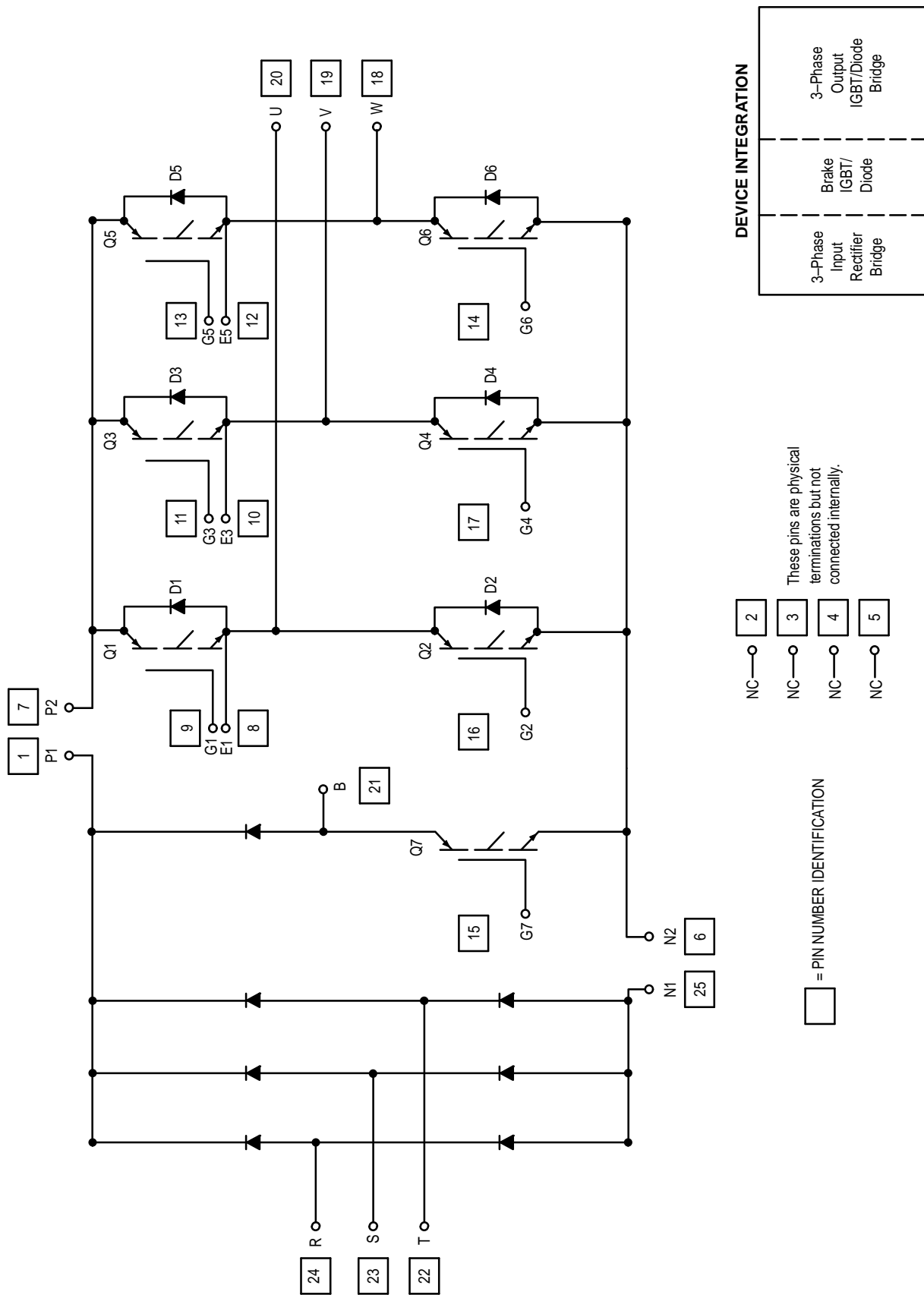


Figure 1. Integrated Power Stage Schematic

Typical Characteristics

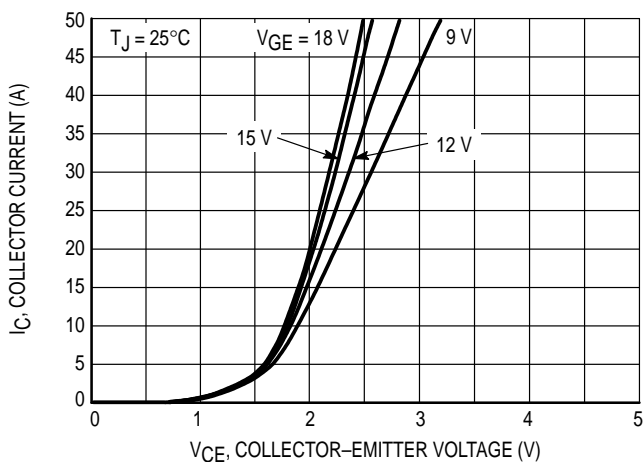


Figure 2. Output Inverter Collector Current I_C versus Collector-Emitter Voltage V_{CE}

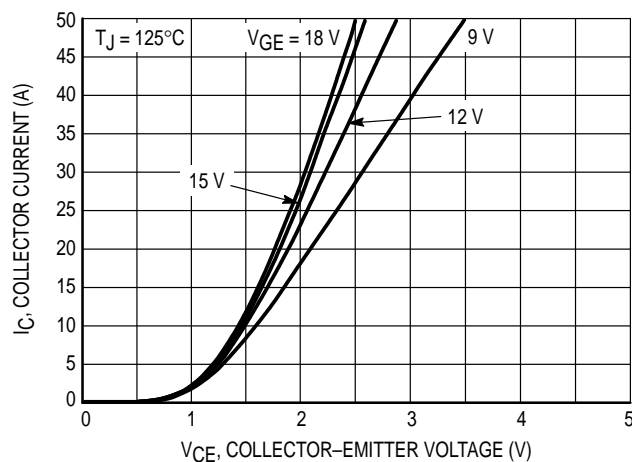


Figure 3. Output Inverter Collector Current I_C versus Collector-Emitter Voltage V_{CE}

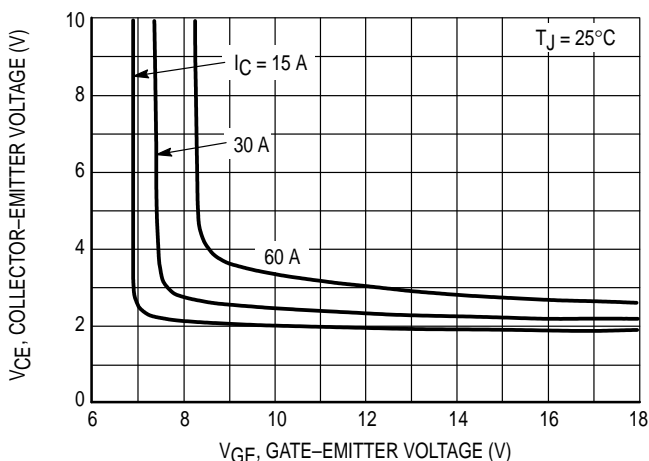


Figure 4. Inverter Collector-Emitter Voltage V_{CE} versus Gate-Emitter Voltage V_{GE}

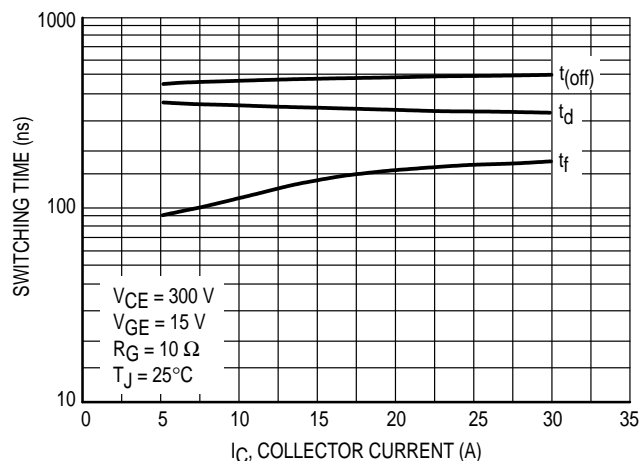


Figure 5. Inverter Switching Time t_d , t_f , $t_{(off)}$ versus Collector Current I_C

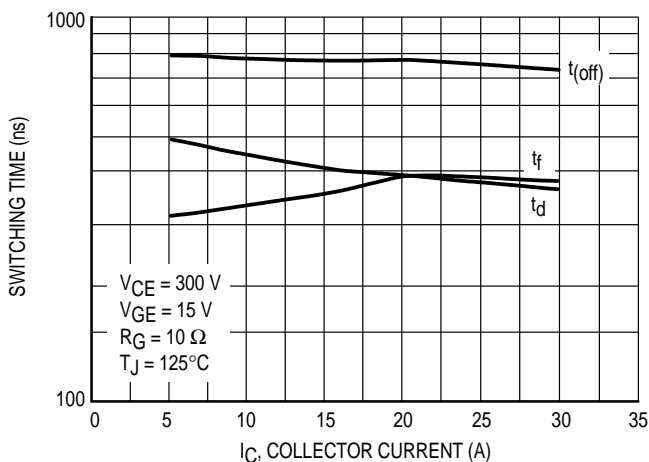


Figure 6. Inverter Switching Time t_d , t_f , $t_{(off)}$ versus Collector Current I_C

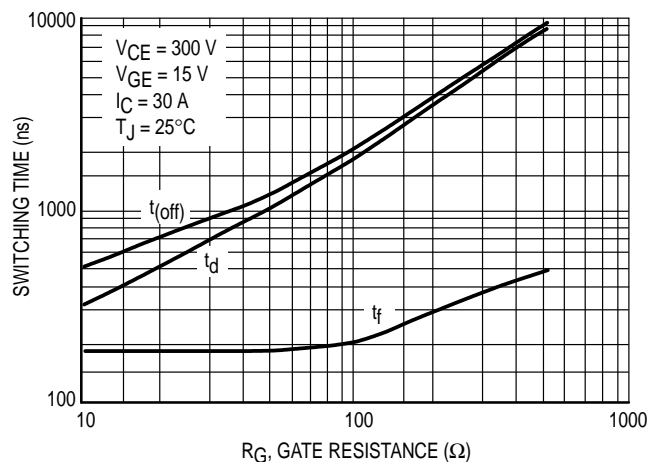


Figure 7. Inverter Switching Time t_d , t_f , $t_{(off)}$ versus Gate Resistance R_G

Typical Characteristics

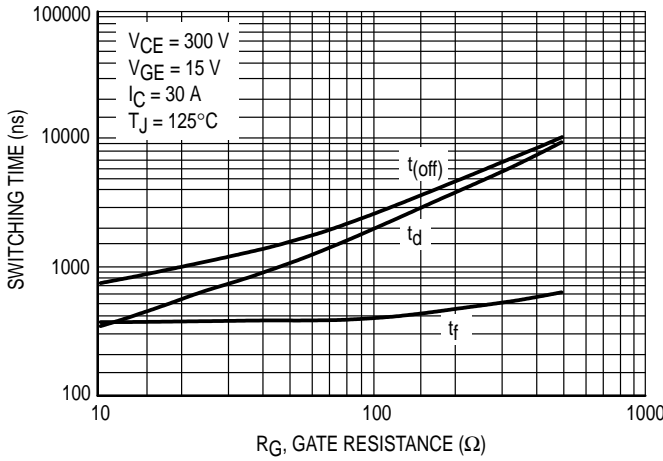


Figure 8. Inverter Switching Time t_d , t_f , $t_{(off)}$ versus Gate Resistance R_G

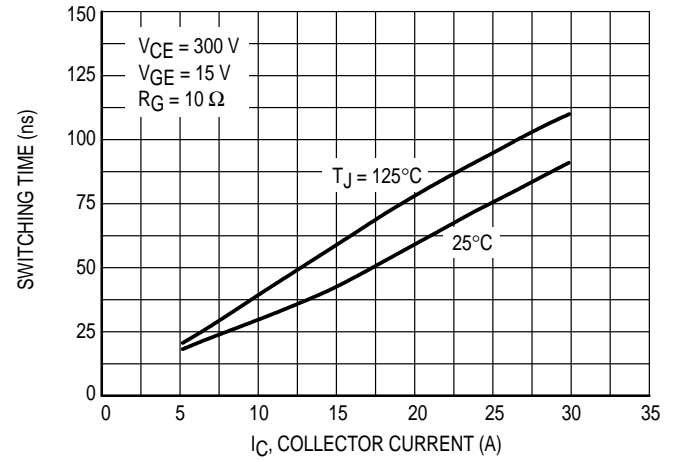


Figure 9. Inverter Switching Time t_f versus Collector Current I_C

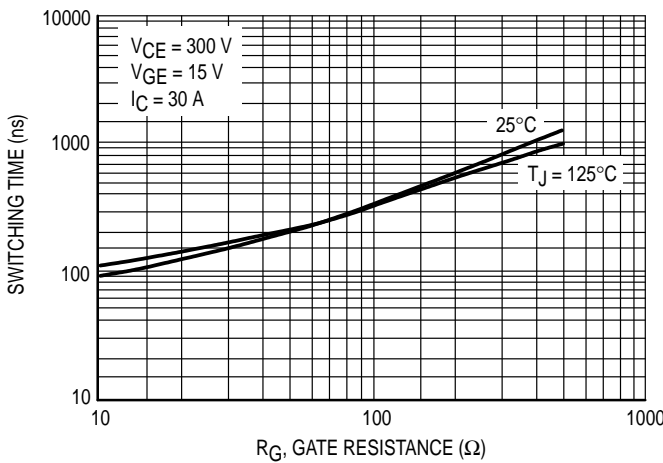


Figure 10. Inverter Switching Time t_f versus Gate Resistance R_G

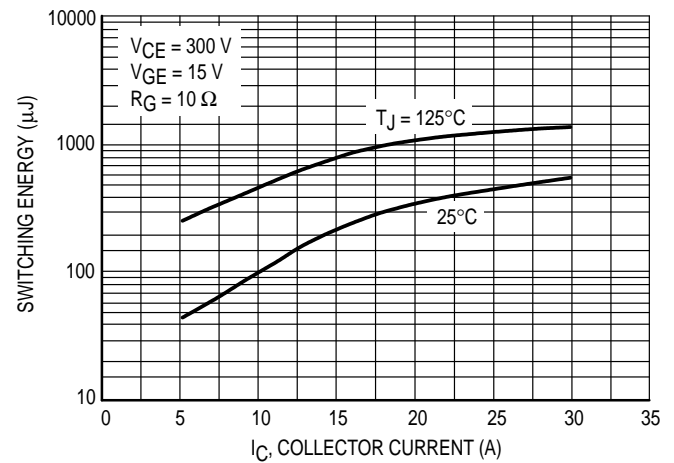


Figure 11. Inverter Switching Energy $E_{(off)}$ versus Collector Current I_C

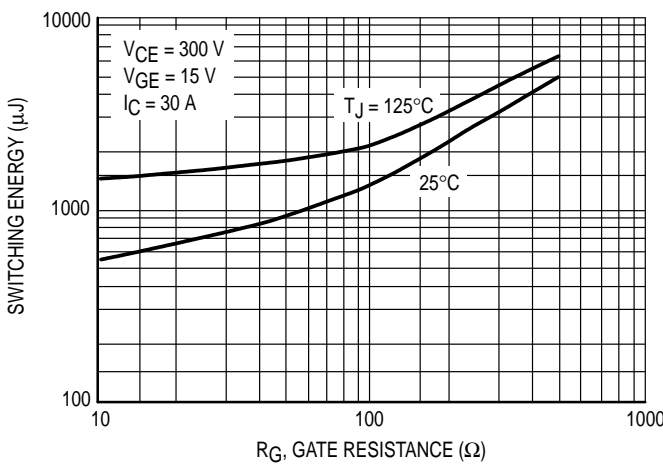


Figure 12. Inverter Switching Energy $E_{(off)}$ versus Gate Resistance R_G

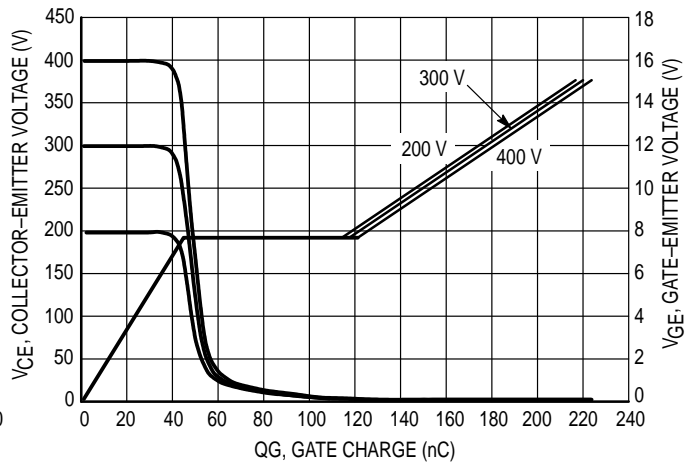


Figure 13. Gate-to-Emitter Voltage versus Gate Charge

Typical Characteristics

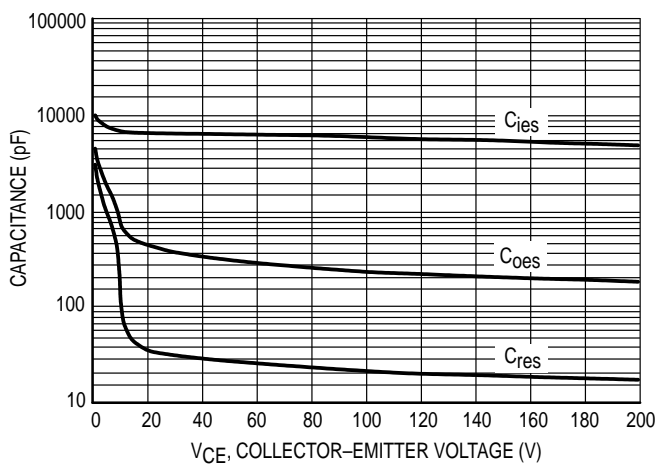


Figure 14. Output Inverter Capacitance versus Collector Voltage V_{CE}

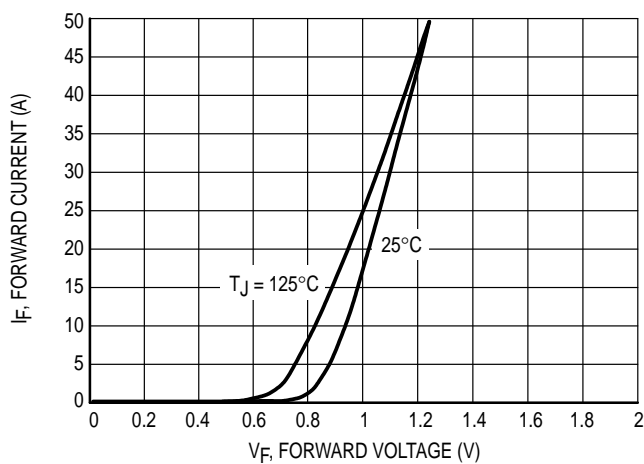


Figure 15. Input Bridge Forward Current I_F versus Forward Voltage V_F

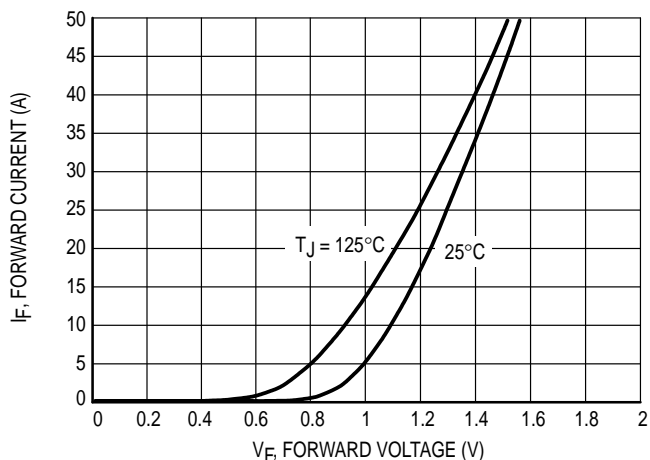


Figure 16. Output Inverter Forward Current I_F versus Forward Voltage V_F

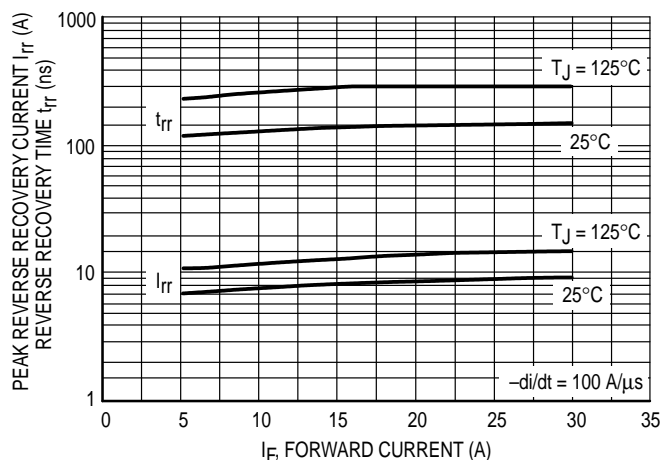


Figure 17. Output Inverter Reverse Recovery t_{rr} , I_{rr} versus Forward Current I_F

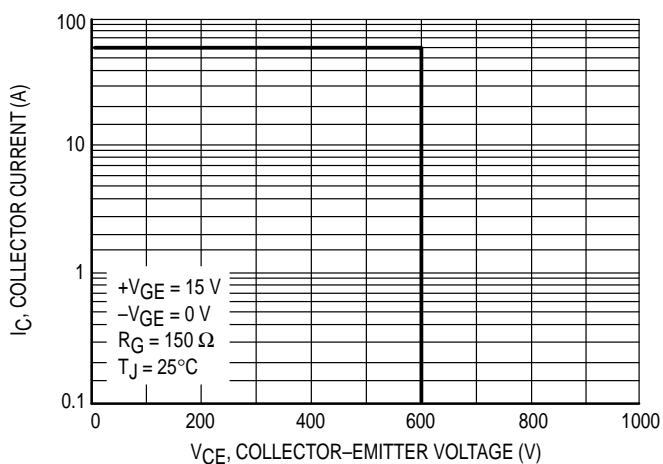


Figure 18. Output Inverter Reversed Biased Safe Operating Area

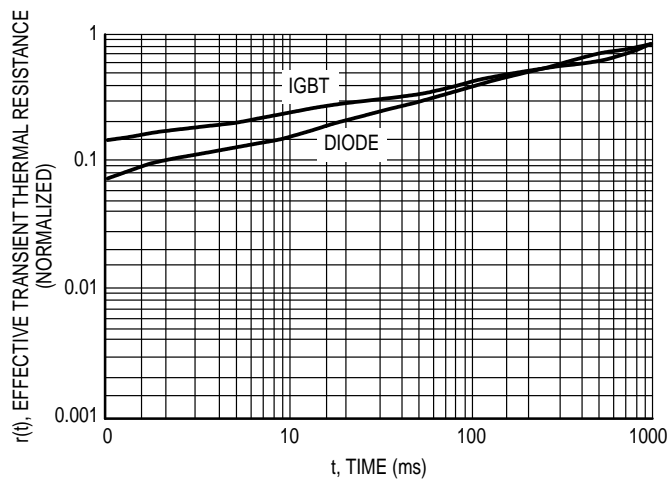
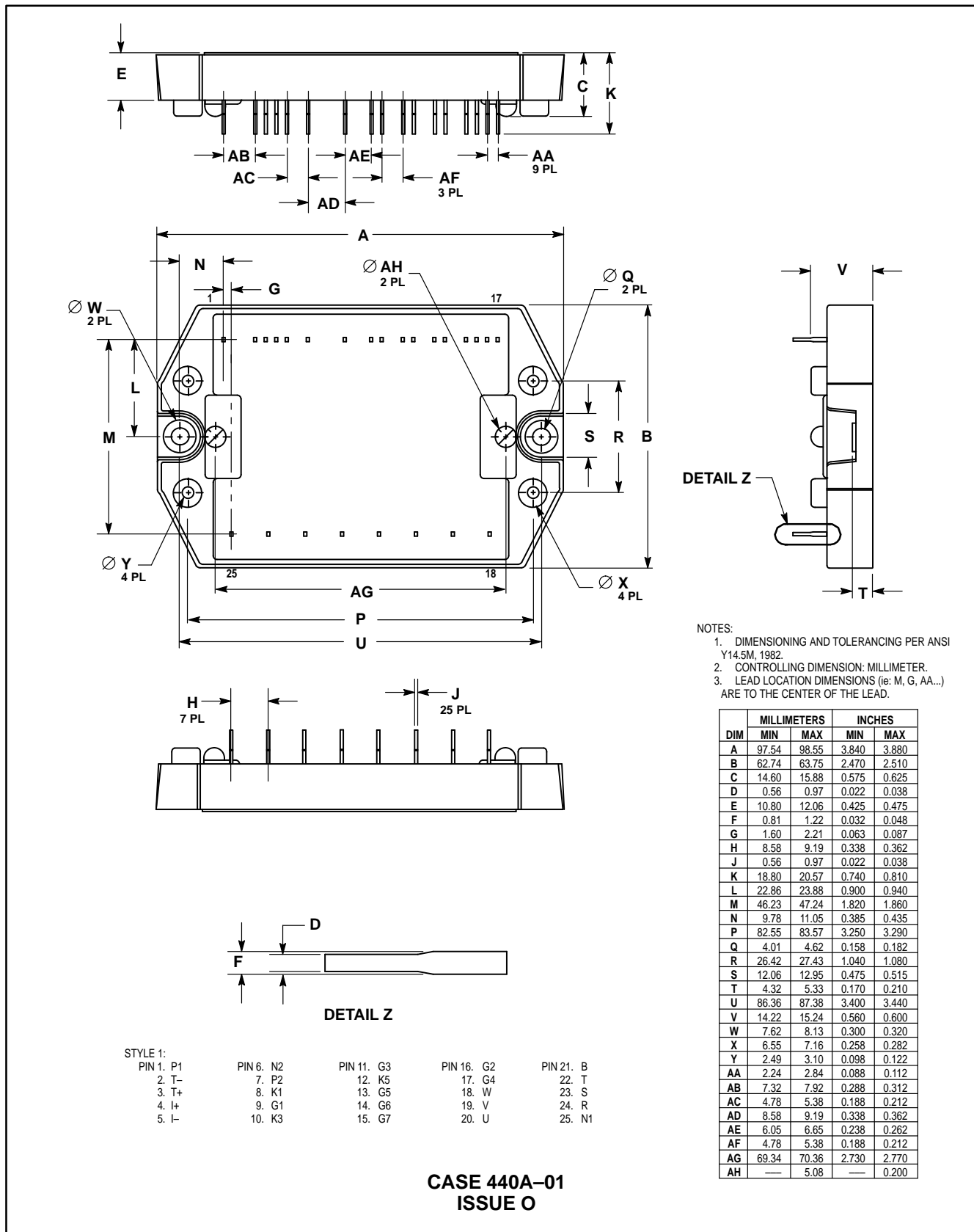



Figure 19. Transient Thermal Resistance

PACKAGE DIMENSIONS



STYLE 1:
 PIN 1. P1 PIN 6. N2 PIN 11. G3 PIN 16. G2 PIN 21. B
 2. T- 7. P2 12. K5 17. G4 22. T
 3. T+ 8. K1 13. G5 18. W 23. S
 4. I+ 9. G1 14. G6 19. V 24. R
 5. I- 10. K3 15. G7 20. U 25. N1

**CASE 440A-01
 ISSUE O**

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P.O. Box 20912; Phoenix, Arizona 85036. 1-800-441-2447

MFAX: RMFAX0@email.sps.mot.com -TOUCHTONE (602) 244-6609
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HONG KONG: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park,
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